# 3.3V ECL Triple 2:1 Multiplexer

# Description

The MC100LVEL59 is a 3.3 V triple 2:1 multiplexer with differential outputs. The output data of the multiplexers can be controlled individually via the select inputs or as a group via the common select input. The flexible selection scheme makes the device useful for both data path and random logic applications.

#### **Features**

- Individual or Common Select Controls
- 500 ps Typical Propagation Delays
- ESD Protection: >2 kV HBM
- The 100 Series Contains Temperature Compensation
- PECL Mode Operating Range: V<sub>CC</sub> = 3.0 V to 3.8 V with V<sub>EE</sub> = 0 V
- NECL Mode Operating Range: V<sub>CC</sub> = 0 V with V<sub>EE</sub> = -3.0 V to -3.8 V
- Internal Input Pulldown Resistors
- Q Output will Default LOW with Inputs Open or at V<sub>EE</sub>
- Meets or Exceeds JEDEC Spec EIA/JESD78 IC Latchup Test
- Moisture Sensitivity;

Pb Pkg Level 1 Pb-Free Pkg Level 3

For Additional Information, see Application Note AND8003/D

- Flammability Rating: UL 94 V-O @ 0.125 in, Oxygen Index 28 to 34
- Transistor Count = 182 devices
- Pb-Free Packages are Available\*



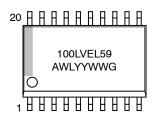
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SO-20 WB DW SUFFIX CASE 751D

#### **MARKING DIAGRAM\***



A = Assembly Location

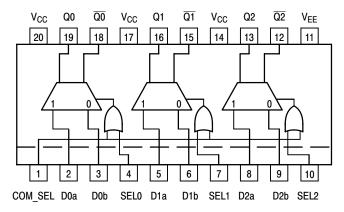
WL = Wafer Lot
 YY = Year
 WW = Work Week
 G = Pb-Free Package

\*For additional marking information, refer to Application Note AND8002/D.

#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



Warning: All  $V_{CC}$  and  $V_{EE}$  pins must be externally connected to Power Supply to guarantee proper operation.

Figure 1. Logic Diagram and Pinout: 20-Lead SOIC (Top View)

**Table 1. PIN DESCRIPTION** 

Pins	Function				
D0a-D2a	ECL Input Data a				
D0b-D2b	ECL Input Data b				
SEL0-SEL2	ECL Individual Select Input				
COM_SEL	ECL Common Select Input				
Q0-Q2; <del>Q0</del> - <del>Q2</del>	ECL Differential Outputs				
V <sub>CC</sub>	Positive Supply				
V <sub>EE</sub>	Negative Supply				

**Table 2. TRUTH TABLE** 

SEL	Data
H	a b

**Table 3. MAXIMUM RATINGS** 

Symbol	Parameter	Condition 1	Condition 2	Rating	Unit
V <sub>CC</sub>	PECL Mode Power Supply	V <sub>EE</sub> = 0 V		8 to 0	V
V <sub>EE</sub>	NECL Mode Power Supply	V <sub>CC</sub> = 0 V		-8 to 0	V
VI	PECL Mode Input Voltage NECL Mode Input Voltage	V <sub>EE</sub> = 0 V V <sub>CC</sub> = 0 V	$\begin{array}{c} V_I \leq V_{CC} \\ V_I \geq V_{EE} \end{array}$	6 to 0 -6 to 0	V V
l <sub>out</sub>	Output Current	Continuous Surge		50 100	mA mA
T <sub>A</sub>	Operating Temperature Range			-40 to +85	°C
T <sub>stg</sub>	Storage Temperature Range			-65 to +150	°C
$\theta_{\sf JA}$	Thermal Resistance (Junction to Ambient)	0 lfpm 500 lfpm	20 SOIC 20 SOIC	140 100	°C/W °C/W
$\theta_{JC}$	Thermal Resistance (Junction to Case)	Standard Board	20 SOIC	30 to 35	°C/W
T <sub>sol</sub>	Wave Solder	<2 to 3 sec @ 248°C		265	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

Table 4. LVPECL DC CHARACTERISTICS V<sub>CC</sub>= 3.3 V; V<sub>EE</sub>= 0.0 V (Note 1)

			−40°C		25°C			85°C			
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current		27	32		27	32		27	32	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 2)	2215	2295	2420	2275	2345	2420	2275	2345	2420	mV
V <sub>OL</sub>	Output LOW Voltage (Note 2)	1470	1605	1745	1490	1595	1680	1490	1595	1680	mV
V <sub>IH</sub>	Input HIGH Voltage	2135		2420	2135		2420	2135		2420	mV
V <sub>IL</sub>	Input LOW Voltage	1490		1825	1490		1825	1490		1825	mV
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW Current	0.5			0.5			0.5			μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 1. Input and output parameters vary 1:1 with V<sub>CC</sub>. V<sub>EE</sub> can vary  $\pm 0.3$  V. 2. Outputs are terminated through a 50  $\Omega$  resistor to V<sub>CC</sub> 2.0 V.

Table 5. LVNECL DC CHARACTERISTICS V<sub>CC</sub>= 0.0 V; V<sub>EE</sub>= -3.3 V (Note 3)

			-40°C		25°C			85°C			
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current		27	32		27	32		27	32	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 4)	-1085	-1005	-880	-1025	-955	-880	-1025	-955	-880	mV
V <sub>OL</sub>	Output LOW Voltage (Note 4)	-1830	-1695	-1555	-1810	-1705	-1620	-1810	-1705	-1620	mV
V <sub>IH</sub>	Input HIGH Voltage	-1165		-880	-1165		-880	-1165		-880	mV
V <sub>IL</sub>	Input LOW Voltage	-1810		-1475	-1810		-1475	-1810		-1475	mV
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW Current	0.5			0.5			0.5			μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 3. Input and output parameters vary 1:1 with  $V_{CC}$ .  $V_{EE}$  can vary ±0.3 V.
- 4. Outputs are terminated through a 50  $\Omega$  resistor to  $V_{CC}$  2.0 V.

Table 6. AC CHARACTERISTICS  $V_{CC}$ = 3.3 V;  $V_{EE}$ = 0.0 V or  $V_{CC}$ = 0.0 V;  $V_{EE}$ = -3.3 V (Note 5)

			−40°C		25°C			85°C				
Symbol	Charac	cteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
f <sub>max</sub>	Maximum Toggle Frequency			TBD			TBD			TBD		GHz
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay	DATA to $Q/\overline{Q}$ SEL to $Q/\overline{Q}$ COM_SEL to $Q/\overline{Q}$	340 340 340		690 690 690	340 340 340		690 690 690	340 340 340		690 690 690	ps
t <sub>skew</sub>	Output-Output Ske	w Any D <sub>n</sub> , D <sub>m</sub> to Q			100			100			100	ps
t <sub>JITTER</sub>	Cycle-to-Cycle Jitte	er		TBD			TBD			TBD		ps
t <sub>r</sub> t <sub>f</sub>	Output Rise/Fall Tir (20% – 80%)	mes Q	200		540	200		540	200		540	ps

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

5.  $V_{EE}$  can vary ±0.3 V.

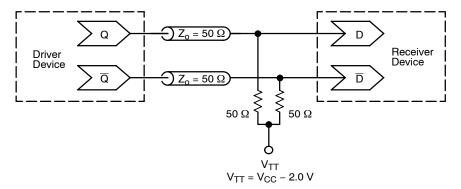


Figure 2. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020/D – Termination of ECL Logic Devices.)

#### **ORDERING INFORMATION**

Device	Package	Package <sup>†</sup>
MC100LVEL59DW	SOIC-20	38 Units / Rail
MC100LVEL59DWG	SOIC-20 (Pb-Free)	38 Units / Rail
MC100LVEL59DWR2	SOIC-20	1000 / Tape & Reel
MC100LVEL59DWR2G	SOIC-20 (Pb-Free)	1000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## **Resource Reference of Application Notes**

AN1405/D - ECL Clock Distribution Techniques

AN1406/D - Designing with PECL (ECL at +5.0 V)

AN1503/D - ECLinPS I/O SPiCE Modeling Kit

AN1504/D - Metastability and the ECLinPS Family

AN1568/D - Interfacing Between LVDS and ECL

AN1672/D - The ECL Translator Guide

AND8001/D - Odd Number Counters Design

AND8002/D - Marking and Date Codes

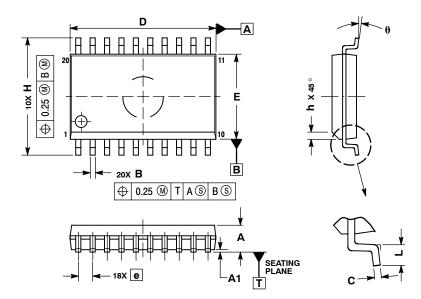
AND8020/D - Termination of ECL Logic Devices

AND8066/D - Interfacing with ECLinPS

AND8090/D - AC Characteristics of ECL Devices

#### PACKAGE DIMENSIONS

**SO-20 WB DW SUFFIX** CASE 751D-05 **ISSUE G** 



#### NOTES

- 1. DIMENSIONS ARE IN MILLIMETERS.
  2. INTERPRET DIMENSIONS AND TOLERANCES
  PER ASME Y14.5M, 1994.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 PER SIDE. DIMENSION B DOES NOT INCLUDE DAMBAR
- PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF B DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIMETERS								
DIM	MIN	MAX							
Α	2.35	2.65							
A1	0.10	0.25							
В	0.35	0.49							
С	0.23	0.32							
D	12.65	12.95							
E	7.40	7.60							
е	1.27	BSC							
Н	10.05	10.55							
h	0.25	0.75							
L	0.50	0.90							
θ	0 °	7 °							

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